

Application/Control No. 09/164,429	Applicant(s)/Patent under Reexamination CHUNG ET AL.
Examiner	Art Unit
Kevin Harper	2616

				ISSUE	CL	<u>.AS</u>	SIF	ICATI	ON					
	·	INTERNATIONAL CLASSIFICATION												
CLASS SUBCLASS							Cl	AIMED		IED				
	6	Н	04	L	12	/66		1						
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370	419				Н	04	L	12	/56		1			
379	93.01	225	399.01	418	Н	04	М	11	/00		1			
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					Н	04	М	1	/00					
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(Assistant Examiner) (Date) Kevin C.					Hai	noer	09/04	1/2007	Total Claims Allowed: 34					
(Primary E						·		(Date)		O.G. Print Fi				
(Legal Instruments Examiner) (Date)										42				

◯ Claims renumbered in the same order as presented by applicant							☑ CPA			☐ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original	Final	Original		Final	Original		Final	Original		Final	Original
	1	1		31	1		61		91		·	121			151			181
	2			32	1		62		92			122			152			182
	3	1		33			63		93			123			153			183
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	5] ,		35			65		95			125			155			185
	6			36			66		96			126			156			186
	7			37			67		97			127			157			187
	8			38			68		98			128			158			188
	9			39			69		99			129			159			189
	10			40			70		100			130			160			190
	11			41			71		101			131			161			191
	12			42			72		102			132			162			192
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	14			44			74		104			134			164			194
	15]		45			75		105			135			165			195
	16	·		46			76		106			136			166			196
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	27			57			87		117			147			177			207
	28			58			88		118			148			178			208
	29			59			89		119			149			179			209
	30			60	L		90		120			150			180			210